- Controlled Baseline

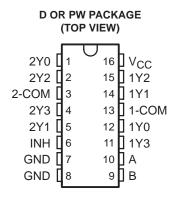
 One Assembly/Test Site, One Fabrication Site
- Extended Temperature Performance of -40°C to 105°C
- Enhanced Diminishing Manufacturing Sources (DMS) Support
- Enhanced Product-Change Notification
- Qualification Pedigree[†]
- Supports Mixed-Mode Voltage Operation on All Ports

• Fast Switching

[†] Component qualification in accordance with JEDEC and industry standards to ensure reliable operation over an extended temperature range. This includes, but is not limited to, Highly Accelerated Stress Test (HAST) or biased 85/85, temperature cycle, autoclave or unbiased HAST, electromigration, bond intermetallic life, and mold compound life. Such qualification testing should not be viewed as justifying use of this component beyond specified performance and environmental limits.

description/ordering information

- High On-Off Output-Voltage Ratio
- Low Crosstalk Between Switches
- Extremely Low Input Current
- ESD Protection Exceeds JESD 22
 - 2000-V Human-Body Model (A114-A)
 - 200-V Machine Model (A115-A)
 - 1000-V Charged-Device Model (C101)



This dual 4-channel CMOS analog multiplexer/demultiplexer is designed for 2-V to 5.5-V V_{CC} operation.

The SN74LV4052A handles both analog and digital signals. Each channel permits signals with amplitudes up to 5.5 V (peak) to be transmitted in either direction.

Applications include signal gating, chopping, modulation or demodulation (modem), and signal multiplexing for analog-to-digital and digital-to-analog conversion systems.

ORDERING INFORMATION

| TA | PACK | AGE‡ | ORDERABLE PART NUMBER | TOP-SIDE MARKING | |
|----------------|------------|---------------|--------------------------|---------------------|--|
| -40°C to 105°C | SOIC – D | Tape and reel | SN74LV4052ATDREP | LV4052ATEP | |
| | TSSOP – PW | Tape and reel | SN74LV4052ATPWREP | L4052EP | |

[‡] Package drawings, standard packing quantities, thermal data, symbolization, and PCB design guidelines are available at www.ti.com/sc/package.

FUNCTION TABLE

| | INPUTS | | ON |
|-----|--------|---|----------|
| INH | В | Α | CHANNEL |
| L | L | L | 1Y0, 2Y0 |
| L | L | Н | 1Y1, 2Y1 |
| L | н | L | 1Y2, 2Y2 |
| L | Н | Н | 1Y3, 2Y3 |
| Н | Х | Х | None |



Please be aware that an important notice concerning availability, standard warranty, and use in critical applications of Texas Instruments semiconductor products and disclaimers thereto appears at the end of this data sheet.

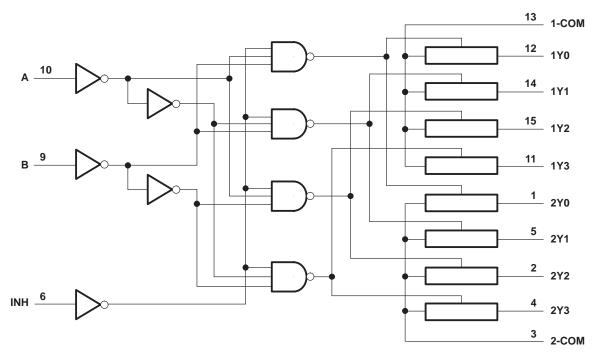
PRODUCTION DATA information is current as of publication date. Products conform to specifications per the terms of Texas Instruments standard warranty. Production processing does not necessarily include testing of all parameters.



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logic diagram (positive logic)



absolute maximum ratings over operating free-air temperature range (unless otherwise noted)[†]

| Supply voltage range, V_{CC} Input voltage range, V_I (see Note 1) Switch I/O voltage range, V_{IO} (see Notes 1 and 2) Input clamp current, I_{IK} ($V_I < 0$) I/O diode current, I_{IOK} ($V_{IO} < 0$) Switch through current, I_T ($V_{IO} = 0$ to V_{CC}) Continuous current through V_{CC} or GND Package thermal impedance $0 \times (acc Note 2)$; D package | 0.5 V to 7.0 V 0.5 V to V _{CC} + 0.5 V 20 mA 50 mA ±25 mA ±50 mA |
|--|--|
| Package thermal impedance, θ_{JA} (see Note 3): D package | 73°C/W |
| PW package | |
| Storage temperature range, T _{stg} | –65°C to 150°C |

[†] Stresses beyond those listed under "absolute maximum ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated under "recommended operating conditions" is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

NOTES: 1. The input and output negative-voltage ratings may be exceeded if the input and output current ratings are observed. 2. This value is limited to 5.5 V maximum.

3. The package thermal impedance is calculated in accordance with JESD 51-7.



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recommended operating conditions (see Note 4)

| | | | MIN | MAX | UNIT | |
|-----------------------|--|------------------------------------|---------------------|---------------------|------|--|
| VCC | Supply voltage | | 2† | 5.5 | V | |
| | | $V_{CC} = 2 V$ | 1.5 | | | |
| N/ | | V_{CC} = 2.3 V to 2.7 V | $V_{CC} \times 0.7$ | | V | |
| VIH | High-level input voltage, control inputs | V _{CC} = 3 V to 3.6 V | $V_{CC} \times 0.7$ | | V | |
| | | $V_{CC} = 4.5 V \text{ to } 5.5 V$ | $V_{CC} \times 0.7$ | | | |
| | | $V_{CC} = 2 V$ | | 0.5 | | |
| | Level Investigation Report and the Provide | V_{CC} = 2.3 V to 2.7 V | | $V_{CC} \times 0.3$ | | |
| VIL | Low-level input voltage, control inputs | $V_{CC} = 3 V \text{ to } 3.6 V$ | | $V_{CC} \times 0.3$ | V | |
| | | $V_{CC} = 4.5 V \text{ to } 5.5 V$ | | $V_{CC} \times 0.3$ | | |
| VI | Control input voltage | | 0 | 5.5 | V | |
| VIO | Input/output voltage | | 0 | VCC | V | |
| | | V_{CC} = 2.3 V to 2.7 V | | 200 | | |
| $\Delta t / \Delta v$ | Input transition rise or fall rate | V _{CC} = 3 V to 3.6 V | | 100 | ns/V | |
| | | V _{CC} = 4.5 V to 5.5 V | | 20 | | |
| ТА | Operating free-air temperature | | -40 | 105 | °C | |

[†] With supply voltages at or near 2 V, the analog switch on-state resistance becomes very nonlinear. It is recommended that only digital signals be transmitted at these low supply voltages.

NOTE 4: All unused inputs of the device must be held at V_{CC} or GND to ensure proper device operation. Refer to the TI application report, *Implications of Slow or Floating CMOS Inputs*, literature number SCBA004.

electrical characteristics over recommended operating free-air temperature range (unless otherwise noted)

| I | PARAMETER | TEST CONDITIONS | Vcc | MIN MAX | UNIT | |
|--------------------|-------------------------------------|--|---------------|---------|------|--|
| | 0 | | 2.3 V | 225 | | |
| ron | On-state switch resistance | $I_T = 2 \text{ mA}, V_I = V_{CC} \text{ or GND}, V_{INH} = V_{IL}$, (see Figure 1) | 3 V | 190 | Ω | |
| | | | 4.5 V | 100 | | |
| | D I I I I | | 2.3 V | 600 | | |
| ^r on(p) | Peak on-state resistance | $I_T = 2 \text{ mA}, V_I = V_{CC}$ to GND, $V_{INH} = V_{IL}$ | 3 V | 225 | Ω | |
| | | 4.5 V | 125 | | | |
| | Difference in | | 2.3 V | 40 | | |
| Δr_{on} | on-state resistance | $I_T = 2 \text{ mA}, V_I = V_{CC}$ to GND, $V_{INH} = V_{IL}$ | 3 V | 30 | Ω | |
| | between switches | | 4.5 V | 20 | | |
| lj – | Control input current | VI = 5.5 V or GND | 0 to 5.5 V | ±1 | μΑ | |
| IS(off) | Off-state switch leakage current | $V_I = V_{CC}$ and $V_O = GND$, or $V_I = GND$ and $V_O = V_{CC}$, $V_{INH} = V_{IH}$, (see Figure 2) | 5.5 V | ±1 | μA | |
| I _{S(on)} | On-state switch leakage current | $V_I = V_{CC}$ or GND, $V_{INH} = V_{IL}$, (see Figure 3) | 5.5 V | ±1 | μΑ | |
| ICC | Supply current | $V_I = V_{CC} \text{ or } GND$ | 5.5 V | 20 | μA | |



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switching characteristics over recommended operating free-air temperature range, V_{CC} = 3.3 V \pm 0.3 V (unless otherwise noted)

| | PARAMETER | FROM (INPUT) | TO (OUTPUT) | TEST CONDITIONS | MIN | МАХ | UNIT |
|--------------------------------------|------------------------|-----------------|----------------|---|-----|-----|------|
| ^t PLH ^t PHL | Propagation delay time | COM or Y | Y or COM | C _L = 50 pF, (see Figure 4) | | 12 | ns |
| ^t PZH ^t PZL | Enable delay time | INH | COM or Y | C _L = 50 pF, (see Figure 5) | | 25 | ns |
| ^t PHZ ^t PLZ | Disable delay time | INH | COM or Y | C _L = 50 pF, (see Figure 5) | | 25 | ns |

switching characteristics over recommended operating free-air temperature range, V_{CC} = 5 V \pm 0.5 V (unless otherwise noted)

| | PARAMETER FROM (INPUT) | | TO (OUTPUT) | TEST CONDITIONS | MIN | МАХ | UNIT |
|--------------------------------------|---------------------------|----------|----------------|---|-----|-----|------|
| ^t PLH ^t PHL | Propagation delay time | COM or Y | Y or COM | C _L = 50 pF, (see Figure 4) | | 8 | ns |
| ^t PZH ^t PZL | Enable delay time | INH | COM or Y | C _L = 50 pF, (see Figure 5) | | 18 | ns |
| ^t PHZ ^t PLZ | Disable delay time | INH | COM or Y | C _L = 50 pF, (see Figure 5) | | 18 | ns |

analog switch characteristics over recommended operating free-air temperature range (unless otherwise noted)

| | FROM | то | TES | ST | | Τ ₄ | λ = 25°C | ; | | |
|---|----------|--|--|-------------------------------------|-------|----------------|----------|-----|------|--|
| PARAMETER | (INPUT) | (OUTPUT) | CONDI | TIONS | vcc | MIN | TYP | MAX | UNIT | |
| | | | C _L = 50 pF, | | 2.3 V | | 30 | | | |
| Frequency response (switch on) | COM or Y | COM or Y Y or COM $R_L = 600 \Omega$, $f_{in} = 1 \text{ MHz} \text{ (sine wave)}$ | | wave) | 3 V | | 35 | | MHz | |
| | | | (see Note 5 and | | 4.5 V | | 50 | | | |
| | | | CL = 50 pF, | | 2.3 V | | -45 | | | |
| Crosstalk (between any switches) | COM or Y | Y or COM | $R_L = 600 \Omega$, $f_{in} = 1 MHz$ (sine wave) (see Note 6 and Figure 7) | | 3 V | | -45 | | dB | |
| (111 11 11) | | | | | 4.5 V | | -45 | | | |
| Crosstalk | | | C _L = 50 pF, | | 2.3 V | | 20 | | | |
| (control input to signal | INH | COM or Y | R _L = 600 Ω, f _{in} = 1 MHz (squ | are wave) | 3 V | | 35 | | mV | |
| output) | | | (see Figure 8) | 4.5 V | | 65 | | | | |
| | | | CL = 50 pF, | | 2.3 V | | -45 | | | |
| Feedthrough attenuation (switch off) | COM or Y | Y or COM | Y or COM $\begin{cases} R_L = 600 \ \Omega, \\ f_{in} = 1 \ MHz \ (sine wave) \end{cases}$ | | 3 V | | -45 | | dB | |
| (ounter on) | | | (see Note 6 and | | 4.5 V | | -45 | | | |
| | | | $C_{L} = 50 \text{ pF},$ | V _I = 2 V _{p-p} | 2.3 V | | 0.1 | | | |
| Sine-wave distortion | COM or Y | Y or COM | $R_L = 10 \text{ k}\Omega,$ $f_{in} = 1 \text{ kHz}$ | VI = 2.5 V _{p-p} | 3 V | | 0.1 | | % | |
| | | | (sine wave) (see Figure 10) | $V_{I} = 4 V_{p-p}$ | 4.5 V | | 0.1 | | | |

NOTES: 5. Adjust fin voltage to obtain 0 dBm at output. Increase fin frequency until dB meter reads -3 dB.

6. Adjust fin voltage to obtain 0 dBm at input.



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operating characteristics, $T_A = 25^{\circ}C$

| | PARAMETER | TEST CO | NDITIONS | TYP | UNIT |
|-----|-------------------------------|-------------------------|------------|------|------|
| Cpd | Power dissipation capacitance | C _L = 50 pF, | f = 10 MHz | 11.8 | pF |

PARAMETER MEASUREMENT INFORMATION

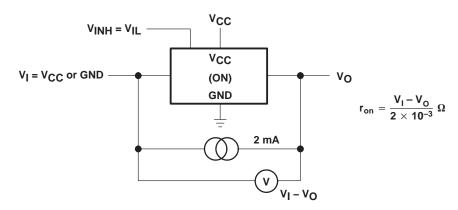
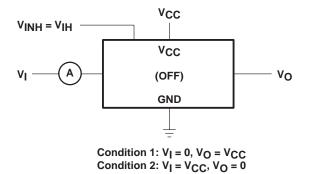


Figure 1. On-State Resistance Test Circuit





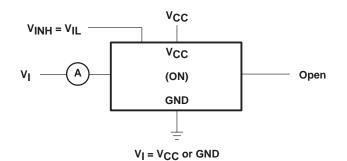
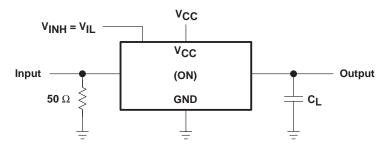


Figure 3. On-State Switch Leakage-Current Test Circuit



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PARAMETER MEASUREMENT INFORMATION





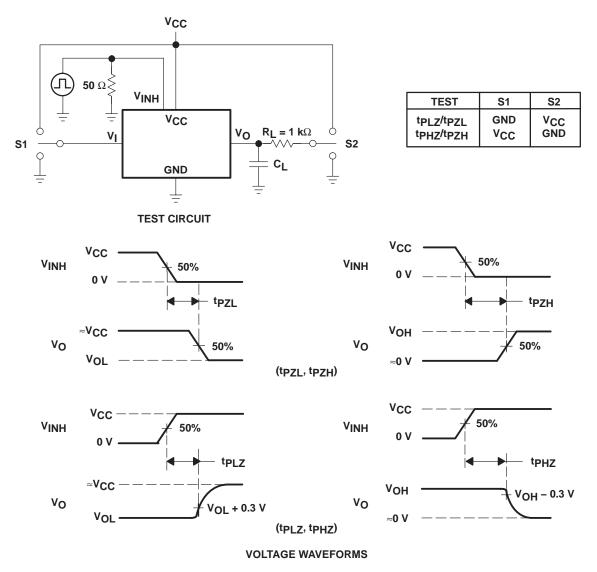
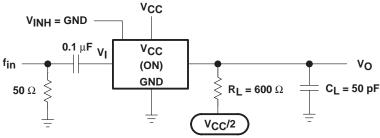


Figure 5. Switching Time (t_{PZL} , t_{PLZ} , t_{PZH} , t_{PHZ}), Control to Signal Output



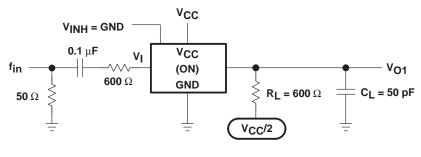
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PARAMETER MEASUREMENT INFORMATION



NOTE A: fin is a sine wave.

Figure 6. Frequency Response (Switch On)



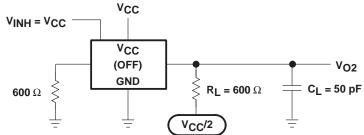


Figure 7. Crosstalk Between Any Two Switches

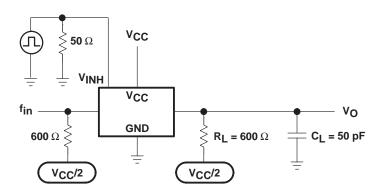
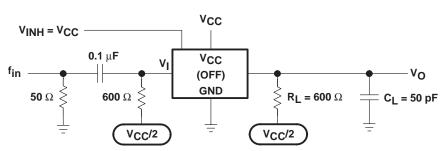


Figure 8. Crosstalk Between Control Input and Switch Output



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PARAMETER MEASUREMENT INFORMATION

Figure 9. Feedthrough Attenuation (Switch Off)

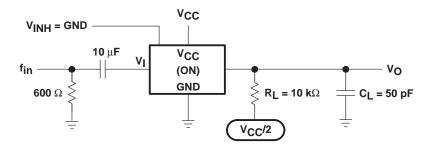


Figure 10. Sine-Wave Distortion





17-Dec-2015

PACKAGING INFORMATION

| Orderable Device | Status | Package Type | Package Drawing | Pins | Package Qty | Eco Plan | Lead/Ball Finish | MSL Peak Temp | Op Temp (°C) | Device Marking | Samples |
|-------------------|--------|--------------|--------------------|------|----------------|----------------------------|------------------|--------------------|--------------|----------------|---------|
| SN74LV4052ATPWREP | ACTIVE | TSSOP | PW | 16 | 2000 | Green (RoHS & no Sb/Br) | CU NIPDAU | Level-1-260C-UNLIM | -40 to 105 | L4052EP | Samples |
| V62/03665-01XE | ACTIVE | TSSOP | PW | 16 | 2000 | Green (RoHS & no Sb/Br) | CU NIPDAU | Level-1-260C-UNLIM | -40 to 105 | L4052EP | Samples |

⁽¹⁾ The marketing status values are defined as follows:

ACTIVE: Product device recommended for new designs.

LIFEBUY: TI has announced that the device will be discontinued, and a lifetime-buy period is in effect.

NRND: Not recommended for new designs. Device is in production to support existing customers, but TI does not recommend using this part in a new design.

PREVIEW: Device has been announced but is not in production. Samples may or may not be available.

OBSOLETE: TI has discontinued the production of the device.

(2) Eco Plan - The planned eco-friendly classification: Pb-Free (RoHS), Pb-Free (RoHS Exempt), or Green (RoHS & no Sb/Br) - please check http://www.ti.com/productcontent for the latest availability information and additional product content details.

TBD: The Pb-Free/Green conversion plan has not been defined.

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the die and leadframe. The component is otherwise considered Pb-Free (RoHS compatible) as defined above.

Green (RoHS & no Sb/Br): TI defines "Green" to mean Pb-Free (RoHS compatible), and free of Bromine (Br) and Antimony (Sb) based flame retardants (Br or Sb do not exceed 0.1% by weight in homogeneous material)

⁽³⁾ MSL, Peak Temp. - The Moisture Sensitivity Level rating according to the JEDEC industry standard classifications, and peak solder temperature.

⁽⁴⁾ There may be additional marking, which relates to the logo, the lot trace code information, or the environmental category on the device.

⁽⁵⁾ Multiple Device Markings will be inside parentheses. Only one Device Marking contained in parentheses and separated by a "~" will appear on a device. If a line is indented then it is a continuation of the previous line and the two combined represent the entire Device Marking for that device.

⁽⁶⁾ Lead/Ball Finish - Orderable Devices may have multiple material finish options. Finish options are separated by a vertical ruled line. Lead/Ball Finish values may wrap to two lines if the finish value exceeds the maximum column width.

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PACKAGE OPTION ADDENDUM

17-Dec-2015

In no event shall TI's liability arising out of such information exceed the total purchase price of the TI part(s) at issue in this document sold by TI to Customer on an annual basis.

OTHER QUALIFIED VERSIONS OF SN74LV4052A-EP :

Catalog: SN74LV4052A

• Automotive: SN74LV4052A-Q1

NOTE: Qualified Version Definitions:

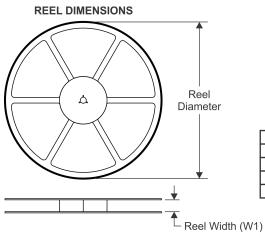
- Catalog TI's standard catalog product
- Automotive Q100 devices qualified for high-reliability automotive applications targeting zero defects

PACKAGE MATERIALS INFORMATION

www.ti.com

Texas Instruments

TAPE AND REEL INFORMATION





QUADRANT ASSIGNMENTS FOR PIN 1 ORIENTATION IN TAPE



| *All dimensions are nominal | | | | | | | | | | | | |
|-----------------------------|-----------------|--------------------|----|------|--------------------------|--------------------------|------------|------------|------------|------------|-----------|------------------|
| Device | Package Type | Package Drawing | | SPQ | Reel Diameter (mm) | Reel Width W1 (mm) | A0 (mm) | B0 (mm) | K0 (mm) | P1 (mm) | W (mm) | Pin1 Quadrant |
| SN74LV4052ATPWREP | TSSOP | PW | 16 | 2000 | 330.0 | 12.4 | 6.9 | 5.6 | 1.6 | 8.0 | 12.0 | Q1 |

TEXAS INSTRUMENTS

www.ti.com

PACKAGE MATERIALS INFORMATION

3-Dec-2015



*All dimensions are nominal

| Device | Package Type | Package Drawing | Pins | SPQ | Length (mm) | Width (mm) | Height (mm) |
|-------------------|--------------|-----------------|------|------|-------------|------------|-------------|
| SN74LV4052ATPWREP | TSSOP | PW | 16 | 2000 | 367.0 | 367.0 | 35.0 |

PW (R-PDSO-G16)

PLASTIC SMALL OUTLINE



NOTES:

A. All linear dimensions are in millimeters. Dimensioning and tolerancing per ASME Y14.5M-1994. β . This drawing is subject to change without notice.

Body length does not include mold flash, protrusions, or gate burrs. Mold flash, protrusions, or gate burrs shall not exceed 0,15 each side.

Body width does not include interlead flash. Interlead flash shall not exceed 0,25 each side.

E. Falls within JEDEC MO-153





NOTES: A. All linear dimensions are in millimeters.

- B. This drawing is subject to change without notice.
- C. Publication IPC-7351 is recommended for alternate designs.
- D. Laser cutting apertures with trapezoidal walls and also rounding corners will offer better paste release. Customers should contact their board assembly site for stencil design recommendations. Refer to IPC-7525 for other stencil recommendations.
- E. Customers should contact their board fabrication site for solder mask tolerances between and around signal pads.



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